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PAPER

Enhancement of photocurrent and photocatalytic activity of ZnO hybridized with graphite-like C₃N₄†

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A ZnO photocatalyst was hybridized with graphite-like C₃N₄ via a monolayer-dispersed method. After hybridization with C₃N₄, the photocurrent of ZnO was enhanced by 5 times under UV irradiation and a photocurrent under visible light irradiation was observed. The photocatalytic activity of C₃N₄/ZnO under UV irradiation was increased by 3.5 times, the visible light photocatalytic activity was generated and the photocorrosion of ZnO was suppressed completely after ZnO was hybridized with C₃N₄. The enhancement in performance and photocorrosion inhibition under UV irradiation was induced by the high separation efficiency of photoinduced holes from ZnO to the HOMO of C₃N₄. Under visible light irradiation, the electron excited from the HOMO to the LUMO of C₃N₄ could directly inject into the CB of ZnO, making C₃N₄/ZnO present visible light photocatalytic activity. The optimum synergetic effect of C₃N₄/ZnO was found at a weight ratio of 3%, which corresponded to a monolayer dispersion of C₃N₄ on the surface of ZnO.

Introduction

In recent years, photocatalysis has attracted much attention in water treatment due to its total destruction ability of pollutants and broad compound applicability.¹ Among various semiconductor materials in present research, although TiO₂ has been extensively investigated and widely employed, ZnO appears to be a suitable alternative to TiO₂. ZnO is also relatively inexpensive and its photodegradation mechanism is similar to that of TiO₂.^{2,3} Moreover, some studies have highlighted that ZnO exhibits a higher efficiency than TiO₂ in the photocatalytic degradation of some dyes in water and photoelectric conversion.^{4–7} However, the high recombination ratio of photoinduced electron–hole pairs, very poor response to visible light and the photocorrosion

have hindered the application of ZnO in photocatalysis. Some effort has been devoted to reducing the recombination of photo-generated electron–hole pairs and improving the utilization of solar light of ZnO, such as doping,^{8,9} deposition of metals,^{10–12} or combining ZnO with another semiconductor.^{13,14} It is anticipated that ZnO could become an excellent photocatalyst if the photocorrosion can be suppressed. However, few reports have focused on this topic. It has been reported by He and co-workers that a ZnO/reduced graphite oxide composite exhibited higher photocatalytic activity and a photocorrosion improvement.¹⁵ Comparelli and co-workers found that surface organic coating of ZnO could provide the oxide with photocorrosion resistance and pH variation.¹⁶

Materials with delocalized conjugated π structures have been extensively studied in electron-transfer processes due to their rapid photoinduced charge separation and a relatively slow charge recombination.¹⁷ A delocalized conjugated π structure material combined with a semiconductor may act as a novel “dyade” type structure which could form a common conjugated

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Broader context

Semiconductor photocatalysis has attracted considerable attention since it has great potential in environmental remediation and hydrogen energy production. Although TiO₂ has been extensively investigated and widely employed, ZnO appears to be a suitable alternative to TiO₂. ZnO is also relatively inexpensive and its photodegradation mechanism is similar to that of TiO₂. But the photocorrosion, the high recombination ratio of photoinduced electron–hole pairs and very poor response to visible light have hindered the application of ZnO in photocatalysis. This article reports the first example of a C₃N₄-hybridized ZnO photocatalyst to enhance the photocatalytic activity and suppress the photocorrosion. The as-prepared C₃N₄-hybridized ZnO possesses significantly enhanced UV light photocatalytic activity, visible light photocatalytic activity and excellent antiphotocorrosion ability.

system and improve the photocatalytic activity in the complete spectral range.^{18,19} Our group has developed conjugative π structure material hybridized ZnO as efficient photocatalysts and successfully suppressed the photocorrosion, for example using C₆₀,²⁰ polyaniline,²¹ and graphite.²² Graphite-like C₃N₄ (denoted as C₃N₄) is the most stable material of all the carbon nitride allotropes under ambient conditions.²³ C₃N₄ possesses a very high thermal and chemical stability; it has attracted a great deal of scientific interest due to its outstanding mechanical, electrical, thermal, and optical properties.²⁴ Some studies have focused on the applications of C₃N₄ materials in photo-splitting water^{25–30} and organic pollutant degradation.^{31,32} Some effort has been devoted to enhancing the photocatalytic activity of C₃N₄, such as by dye-sensitization,²⁶ transition metal-modification,²⁹ and combination of C₃N₄ with a metal to form heterojunctions.³⁰

C₃N₄ has a conjugated π structure and the combination of ZnO and C₃N₄ may be an ideal system to achieve an enhanced charge separation in electron-transfer processes and suppress the photocorrosion. To the best of our knowledge, there has been no report regarding the introduction of C₃N₄ to ZnO to enhance the photocatalytic activity and suppress the photocorrosion. Herein, we present the first example of a C₃N₄-hybridized ZnO photocatalyst fabricated by the chemisorption method and demonstrate that a hybrid effect exists between ZnO and C₃N₄. The photoelectrochemical performances and methylene blue (MB) degradation performance were investigated systematically. After hybridization with C₃N₄, the photocurrent of ZnO was enhanced by 5 times under UV irradiation and a photocurrent under visible light irradiation was observed. The degradation results indicated that the introduction of C₃N₄ to ZnO can effectively enhance the UV light photocatalytic activity, generate visible photocatalytic activity, and suppress the photocorrosion. The synergic effect between ZnO and C₃N₄, the possible mechanisms of photocorrosion inhibition and enhancement of photocatalytic activity *via* hybridization were also investigated.

Experimental section

Preparation of the C₃N₄/ZnO photocatalyst

Melamine (C₃H₆N₆) was purchased from Sinopharm Chemical Reagent Corp, P. R. China; ZnO (particle diameter 20 nm, surface area 37.741 m² g⁻¹) was obtained from Nanjing Haitai Nanometer Materials Corp, P. R. China. All other reagents used in this research were analytically pure and used without further purification. The C₃N₄ used in this study was prepared by heating melamine to 550 °C for 2 h in N₂ atmosphere according to the literature.²⁵ The typical preparation of C₃N₄/ZnO photocatalysts was as follows: firstly, an appropriate amount of C₃N₄ was added into methanol then the beaker was placed in an ultrasonic bath for 30 min to completely disperse the C₃N₄. The ZnO powder was added into the above solution and stirred in a fume hood for 24 h. After volatilization of the methanol, an opaque powder was obtained after drying at 100 °C in N₂ atmosphere. According to this method, different mass ratios of C₃N₄/ZnO photocatalysts from 1% to 8% were synthesized.

To investigate the transition of photogenerated electrons before and after C₃N₄ hybridization, ZnO and C₃N₄/ZnO electrodes were prepared as follows: 5 mg of the as-prepared

photocatalyst was suspended in 5 mL ethanol to produce a slurry, which was then dip-coated onto a 2 cm × 4 cm indium-tin oxide (ITO) glass electrode. Electrodes were exposed to UV light for 12 h to eliminate ethanol and subsequently calcined at 200 °C for 30 min under N₂ flow (rate = 60 mL min⁻¹). All investigated electrodes were of similar thickness (0.8–1.0 μ m).

Characterization

Fourier transform infrared (FT-IR) spectra were measured by a Perkin Elmer System 2000 infrared spectrometer with KBr as the reference sample. The morphologies and structure of the as-prepared samples were examined with transmission electron microscopy (TEM) by a JEM 1010 electron microscope operated at an accelerating voltage of 100 kV. The high-resolution transmission electron microscopy (HRTEM) images were obtained by Tecnai TF20 transmission electron microscope operated at an accelerating voltage of 200 kV. UV-Vis diffuse reflectance spectroscopy (DRS) was carried out on a Hitachi U-3010 UV-vis spectrophotometer. BaSO₄ was the reference sample. The Brunauer-Emmett-Teller (BET) surface area was measured by ASAP 2010 V5.02H. The crystallinity of the as-prepared sample was characterized by X-ray diffraction (XRD) on Bruker D8-advance diffractometer using Cu-K α radiation ($\lambda = 1.5418$ Å). Thermogravimetric analysis (TG) was performed in air at a heating rate of 10 °C min⁻¹ on a Dupont 1090 thermal analyzer. The concentration of Zn²⁺ in the solution of ZnO and the C₃N₄/ZnO photocatalytic system was measured as follows: at certain time intervals, 10 mL aliquots were sampled and centrifuged 5 times to remove all the particles. The filtrates were determined on a ThermoFisher IRIS Intrepid II XSP ICP-OES instrument. The total organic carbon (TOC) was measured with a Tekmar Dohrmann Apollo 9000 TOC analyzer. The photocurrents were measured on an electrochemical system (CHI-660B, China). UV light was obtained from an 11 W germicidal lamp and visible irradiation was obtained from a 500 W xenon lamp (Institute for Electric Light Sources, Beijing) with a 450 nm cutoff filter. A standard three-electrode cell with a working electrode (as-prepared photocatalyst), a platinum wire as counter electrode, and a standard calomel electrode (SCE) as reference electrode were used in the photoelectric studies. 0.1 M Na₂SO₄ was used as the electrolyte solution. Potentials are given with reference to the SCE. The photoresponses of the photocatalysts as light on and off were measured at 0.0 V.

Photocatalytic experiments

The photocatalytic activities were evaluated by the decomposition of MB under UV light ($\lambda = 254$ nm) and visible light irradiation. The radial flux was measured by a power meter from the Institute of Electric Light Sources, Beijing. UV light was provided by an 11 W UV-light lamp (Institute of Electric Light Sources, Beijing) and the average light intensity was 0.8 mW cm⁻². An aqueous solution of MB (100 mL, 10 mg L⁻¹) was placed in a vessel, and 50 mg photocatalyst was added. Prior to irradiation, the suspensions were magnetically stirred in the dark for about 30 min. At certain time intervals, 2 mL aliquots were sampled and centrifuged to remove the particles. The filtrates were analyzed by recording variations of the maximum

absorption peak (663 nm for MB) using a Hitachi U-3010 UV-vis spectrophotometer. To estimate the photostability of the photocatalysts, 96 h persistent MB degradation of ZnO and $C_3N_4/ZnO-2\%$ were performed. At certain time intervals (24 h, 48 h and 96 h), the MB degradation performance of ZnO and $C_3N_4/ZnO-2\%$ was determined. The visible light was obtained by a halogen-tungsten lamp (provides visible light in the range of 400–800 nm; the main wavelength is about 550 nm) and the average visible light intensity was 1.2 mW cm^{-2} . The method was similar with the UV light degradation. The active species generated in the photocatalytic system could be detected through trapping by *tert*-butyl alcohol (*t*-BuOH) and ethylenediaminetetraacetic acid disodium salt (EDTA-2Na).

Results and discussion

Enhancement of photocatalytic activity and photocurrent

Fig. 1 shows the photocatalytic activity of ZnO and the C_3N_4/ZnO photocatalysts with different loading amounts of C_3N_4 under UV light and visible light irradiation, respectively. The mechanically blended C_3N_4 and ZnO (3%) were used as a reference. The photocatalytic degradation process was fitted to pseudo-first-order kinetics, and the value of the rate constant k is

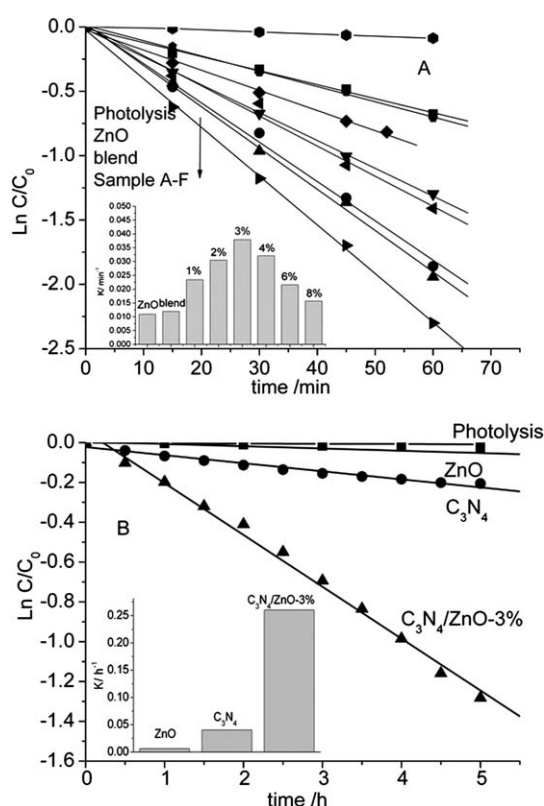


Fig. 1 Photolysis of MB and photocatalytic degradation of MB over ZnO and C_3N_4/ZnO photocatalysts (A) under UV light irradiation ($\lambda = 254 \text{ nm}$) and (B) under visible light irradiation (visible light region in the range of 400–800 nm; the main wavelength is about 550 nm); MB initial concentration = 10 mg L^{-1} . Samples A–F represent C_3N_4/ZnO photocatalysts with 8%, 6%, 1%, 4%, 2%, and 3% of C_3N_4 loaded, respectively. Inserts: degradation rate constant k of ZnO, C_3N_4 and various C_3N_4/ZnO photocatalysts.

equal to the corresponding slope of the fitting line. As can be seen in Fig. 1A, the photocatalytic activity of the blended C_3N_4 and ZnO sample was almost the same as that of the pure ZnO, whereas all of the C_3N_4/ZnO photocatalysts exhibited higher photocatalytic activity than the pure ZnO sample under UV light irradiation. The photocatalytic activity was enhanced gradually with the increasing proportion of C_3N_4 . When the proportion of C_3N_4 reached 3%, the as-prepared photocatalyst exhibited the highest photocatalytic activity. The apparent rate constant k was 0.0379 min^{-1} and was almost 3.5 times as high as that of pure ZnO. However, further increasing the proportion of C_3N_4 , the degradation rate decreased gradually though it remained higher than that of ZnO. It can also be seen from the insert graph of Fig. 1A that the loading amount of C_3N_4 had a great influence on the photocatalytic activity of the as-prepared photocatalysts. The optimal loading amount of C_3N_4 on the surface of ZnO was 3%. To further understand the mineralization property of the as-prepared photocatalyst, the decrease of TOC in the photo-degradation of MB by ZnO and $C_3N_4/ZnO-3\%$ photocatalysts was determined (see supplementary data Figure S1†). It was found that the TOC removal percentage is 64% and 32% for $C_3N_4/ZnO-3\%$ and ZnO after 2 h photocatalytic reaction, respectively. After C_3N_4 modification, the mineralization property of ZnO was evidently enhanced. Under visible light irradiation, since ZnO could not be excited by visible light irradiation, the pure ZnO played no role in degrading MB. After modification with C_3N_4 , ZnO possessed excellent visible light photocatalytic activity (see Fig. 1B), and the photocatalytic activity is much higher than that of pure C_3N_4 . The $C_3N_4/ZnO-3\%$ photocatalyst could degrade MB by 72.3% in 5 h. It was notable that the mechanical blend did not obviously enhance the photocatalytic activity of ZnO, implying that there may be some interaction between ZnO and C_3N_4 that plays an important role in improving the photocatalytic activity.

Photocurrents were measured for $C_3N_4/ZnO-3\%$ and ZnO electrodes to investigate the electronic interaction between C_3N_4 and ZnO (Fig. 2). It was clear that fast and uniform photocurrent responses were observed in both electrodes and the photo-responsive phenomenon was entirely reversible. Under UV light irradiation, the photocurrent of the $C_3N_4/ZnO-3\%$ electrode was about five times as high as that of the pure ZnO electrode (Fig. 2A). Under visible light irradiation, ZnO showed almost no photocurrent response. On the contrary, $C_3N_4/ZnO-3\%$ photocatalyst showed a noticeable photocurrent under visible light irradiation (Fig. 2B). The photocurrent enhancement of the C_3N_4/ZnO photocatalyst indicated an enhanced photoinduced electrons and holes separation, which could be attributed to the synergetic effect of C_3N_4 and the ZnO semiconductor.

Photocorrosion suppression

To estimate the photostability of the photocatalysts, 96 h persistent MB degradation of ZnO and $C_3N_4/ZnO-2\%$ was performed, and the rate constant k at a certain reaction time is shown in Fig. 3. Under UV light irradiation, 72% of MB could be degraded in 2 h when ZnO was used for the first time. After 24 h of photocatalytic reaction, a sharp decrease of photocatalytic activity of pure ZnO can be seen from Fig. 3 and the reaction rate constant k decreased from 0.0107 min^{-1} to 0.0052 min^{-1} . After

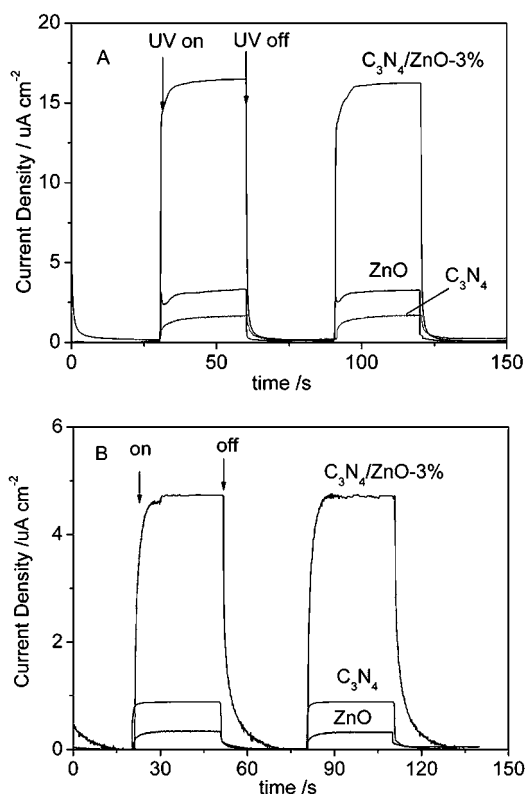


Fig. 2 Photocurrents of ZnO, C_3N_4 and C_3N_4/ZnO electrodes (A) under UV light irradiation ($\lambda = 254$ nm) and (B) under visible light irradiation ($\lambda > 450$ nm) ($[Na_2SO_4] = 0.1$ M).

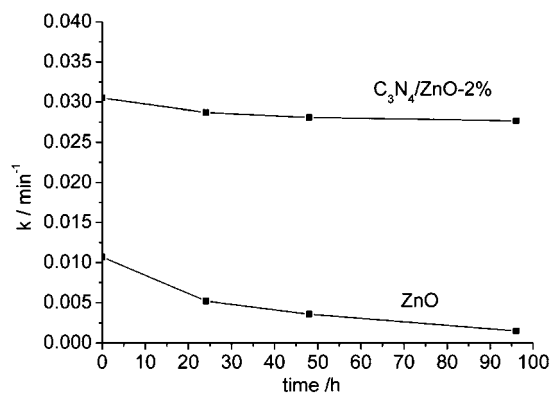


Fig. 3 Photostability experiments of ZnO and C_3N_4/ZnO photocatalysts. (UV light $\lambda = 254$ nm, average light intensity = 0.8 $mW\ cm^{-2}$).

96 h of photocatalytic reaction, the photocorrosion of ZnO was very severe. The photocatalytic degradation of MB was hardly evident, and the reaction rate constant k declined to $0.0015\ min^{-1}$, which was only one-seventh of the initial reaction rate ($0.0107\ min^{-1}$). Interestingly, after hybridization with C_3N_4 , long time photocatalytic reaction did not conspicuously affect the photocatalytic activity of ZnO. The reaction rate constant k decreased from $0.0305\ min^{-1}$ to $0.0277\ min^{-1}$ after 96 h photodegradation, which still preserved 91% of the initial photocatalytic activity. Apparently, the presence of C_3N_4 on the surface of ZnO could inhibit the photocorrosion phenomenon and enhance the stability of the ZnO photocatalyst greatly.

To further investigate the suppression of photocorrosion, XRD patterns, TEM images and ICP-OES were determined before and after photocatalytic reaction. Figure S2 shows the XRD patterns of ZnO and $C_3N_4/ZnO-2\%$ before and after 48 h photocatalytic reaction.[†] For pure ZnO, after 48 h photocatalytic reaction, new diffraction peaks appeared at 27.7° , 32.8° , and 60.1° , which could be attributed to the $Zn_5(OH)_6(CO_3)_2$ phase. The crystalline phase structure of ZnO was obviously destroyed, indicating that severe photocorrosion had taken place. However, the XRD patterns of $C_3N_4/ZnO-2\%$ showed no notable differences before and after 48 h photocatalytic reaction. The TEM images of ZnO and $C_3N_4/ZnO-2\%$ photocatalysts before and after 48 h reaction are shown in Figure S3.[†] Before reaction, the ZnO and $C_3N_4/ZnO-2\%$ samples consisted of agglomerated approximately spherical particles with diameters of 20 nm. After 48 h photocatalytic reaction, for pure ZnO, only loose floccule existed, indicating that the structure of the ZnO crystal had been seriously destroyed. In contrast, for the $C_3N_4/ZnO-2\%$ sample before and after 48 h photocatalytic reaction, it had not exhibited any great changes in morphology, revealing that C_3N_4 -hybridized ZnO was photostable and the photocorrosion was successfully suppressed.

The concentrations of Zn^{2+} in the solution of ZnO and the $C_3N_4/ZnO-2\%$ photocatalytic system before and after photocatalytic reaction are shown in Table 1. After 4 h of reaction, the concentration of Zn^{2+} was $9.485\ \mu g\ mL^{-1}$ and $7.264\ \mu g\ mL^{-1}$ in ZnO and $C_3N_4/ZnO-2\%$ photocatalytic solution, respectively. After 24 h of photocatalytic reaction, the concentration of Zn^{2+} was $389.500\ \mu g\ mL^{-1}$ in the solution of the ZnO photocatalytic system, indicating that the structure of ZnO was destroyed and a large amount of ZnO particles was dissolved in the solution. Interestingly, after 24 h of photocatalytic reaction, the concentration of Zn^{2+} was $8.078\ \mu g\ mL^{-1}$ in the solution of $C_3N_4/ZnO-2\%$ photocatalytic system which was not evidently different from that after 4 h reaction. The ICP results were in good agreement with the results of TEM and XRD, further revealing that the presence of C_3N_4 on the ZnO surface could effectively suppress the photocorrosion of ZnO during the photocatalytic reaction.

Structure and morphology of C_3N_4/ZnO photocatalysts

Fig. 4 shows an HRTEM image of $C_3N_4/ZnO-3\%$ photocatalyst. As can be seen from Fig. 4, the lattice structure of ZnO was very orderly and the outer boundary of the as-prepared sample was distinctly different from the ZnO core. The measured interplanar spacing is 0.136 nm which corresponds to the ZnO (201) plane. The thickness of the C_3N_4 layer coated on the $C_3N_4/ZnO-3\%$ sample was about 0.354 nm, which is close to the scale of

Table 1 The concentrations of Zn^{2+} in the solutions of ZnO and the $C_3N_4/ZnO-2\%$ photocatalytic system before and after different times of photocatalytic reaction

Photocatalyst	Before reaction ($\mu g\ mL^{-1}$)	After 4 h reaction ($\mu g\ mL^{-1}$)	After 24 h reaction ($\mu g\ mL^{-1}$)
ZnO	1.940	9.485	389.500
$C_3N_4/ZnO-2\%$	1.247	7.264	8.078

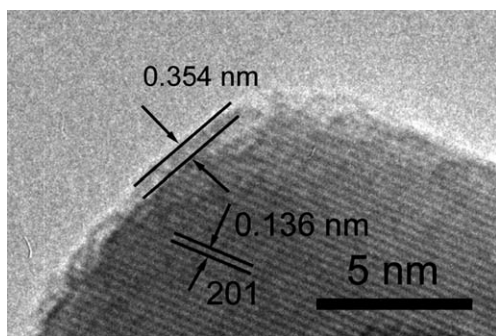


Fig. 4 HRTEM image of C_3N_4/ZnO -3% photocatalyst.

monolayer C_3N_4 (about 0.325 nm).³² Therefore, it can be inferred that the C_3N_4 molecule was dispersed on the surface of ZnO with an approximately monolayer structure.

The amount of C_3N_4 could be obtained by TG analysis (Figure S4†). For pure ZnO, a weight loss occurring from 200 °C to 500 °C could be attributed to the desorption of surface bound water. For pure C_3N_4 , two weight loss regions could be seen in the TG curve. The first weight loss could also be attributed to the desorption of surface bound water. The second weight loss occurring from 500 °C to 720 °C could be assigned to the burning of C_3N_4 . These two weight loss regions could be seen in all C_3N_4/ZnO samples. The amount of C_3N_4 hybridized on the surface of ZnO could be calculated from the second weight loss and is shown in the insert of Figure S4.† Except for the C_3N_4/ZnO -8% sample, the amount of C_3N_4 was nearly consistent to the dosage of C_3N_4 added.

The XRD patterns of ZnO, C_3N_4 and various C_3N_4/ZnO photocatalysts are shown in Fig. 5. As can be seen from Fig. 5 the crystal phase of ZnO did not change after hybridization. All the diffraction peaks of the ZnO can be exactly indexed as the zincite structure (JCPDS 89-1397). There was no crystalline C_3N_4 in the C_3N_4/ZnO photocatalysts with low C_3N_4 loadings, whereas the as-prepared samples with higher C_3N_4 loadings (>3%) exhibited a crystalline C_3N_4 peak; the peak intensities increased with the increase in C_3N_4 loading. Thus, it can be inferred that C_3N_4 was dispersed uniformly on the ZnO surface with low C_3N_4 loadings,³³ while crystalline C_3N_4 appeared only if its loading exceeded a threshold value (3%).

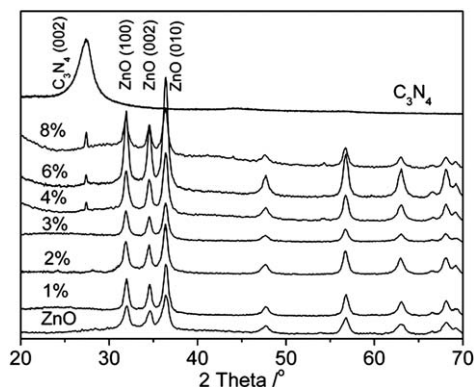


Fig. 5 XRD of ZnO, C_3N_4 and C_3N_4/ZnO photocatalysts.

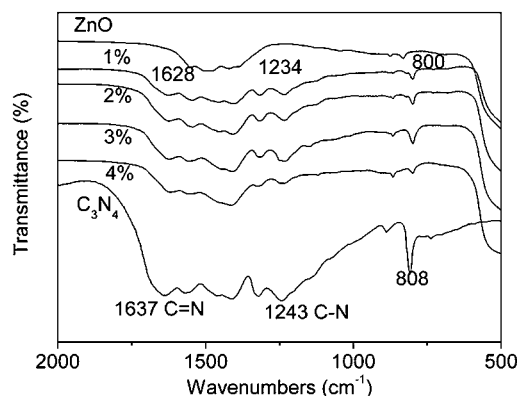


Fig. 6 FT-IR spectra of ZnO, C_3N_4 and C_3N_4/ZnO photocatalysts.

Fig. 6 shows the FT-IR spectra of ZnO and various C_3N_4/ZnO photocatalysts. In the FT-IR spectrum of C_3N_4 , the peaks at 1637 cm^{-1} and 1243 cm^{-1} were attributable to the C=N and C-N stretching vibration modes, respectively.^{34,35} The peak at 808 cm^{-1} was related to the s-triazine ring modes.³⁵ It can be clearly seen that the main characteristic peaks of C_3N_4 and ZnO all appeared in the C_3N_4/ZnO photocatalysts. In the C_3N_4/ZnO photocatalysts, all of the main characteristic peaks of C_3N_4 moved to a lower wavenumber. The red shift of these bands indicated that the bond strengths of C-N and C=N were weakened, suggesting that the conjugated system of C_3N_4 was stretched and a more widely conjugated system containing C_3N_4 and ZnO had already appeared. The FT-IR spectra revealed the existence of C_3N_4 structure and there was a covalent bond between C_3N_4 and ZnO.²¹ This bond may be of significance to transfer carriers and induce a synergetic effect to enhance the photocatalytic activity. The Raman spectra can not be obtained due to the fluorescence of C_3N_4 .

The UV-vis DRS spectra of ZnO and different mass ratios of C_3N_4/ZnO photocatalysts are shown in Fig. 7. As expected, a sharp fundamental absorption edge rises at 410 nm for ZnO. Compared with that of pure ZnO, the C_3N_4/ZnO photocatalysts show the same absorbance edge, but extend the absorbance to the visible region due to the presence of C_3N_4 on the ZnO surface. The absorption edge does not shift for all C_3N_4/ZnO samples, indicating identical band gap energies. The absorption intensity of the prepared samples increases with increasing amounts of C_3N_4 .

Mechanism of enhancement of photoactivity and photocorrosion suppression under UV irradiation

It is well known that the photocatalytic activity is mainly governed by phase structure, adsorption ability, and separation efficiency of photogenerated electrons and holes.^{36,37} As can be seen from the XRD spectra, the crystal phase structure of ZnO was not changed during the hybridization. An adsorption experiment was performed to evaluate the adsorption ability of the ZnO and C_3N_4/ZnO photocatalysts in the dark (see Figure S5†). As can be seen from Figure S5,† after equilibration in the dark for 10 min, 89.2% and 74.9% of MB remained in the solution with pure ZnO and C_3N_4/ZnO -3% photocatalyst, respectively. However, there were no significant changes in the BET surface area (37.741 and 37.832 $m^2 g^{-1}$ for ZnO and

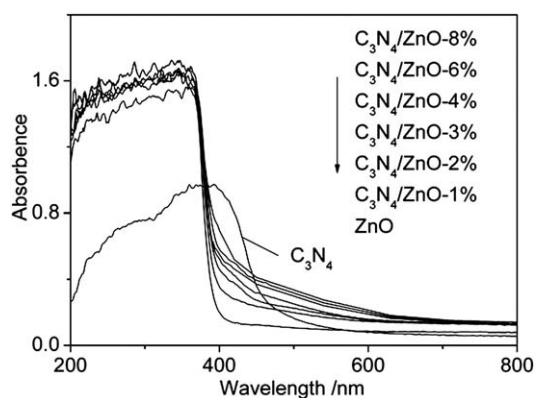


Fig. 7 UV-vis DRS of C_3N_4 , ZnO and C_3N_4/ZnO photocatalysts.

C_3N_4/ZnO -3%, respectively) between ZnO and C_3N_4/ZnO -3%, indicating the MB adsorption should not just originate from simply physical adsorption. The enhancement of adsorption could be contributed to the π - π stacking between MB and C_3N_4 , which was similar to the conjugation between aromatic molecules and graphene.³⁶ MB molecules could be adsorbed on the C_3N_4 surface with offset face to face orientation *via* π - π conjugation until an adsorption-desorption equilibrium is reached. The enhanced adsorptivity was a good supplement for the high photocatalytic activity of the hybridized C_3N_4/ZnO photocatalyst.

It is important to detect the main oxidative species in the photocatalytic process for revealing the photocatalytic mechanism. The main oxidative species in the photocatalytic process could be detected through the trapping experiments of radicals and holes by using *t*-BuOH (radical scavenger)³⁸ and EDTA-2Na (hole scavenger),³⁹ respectively. As shown in Fig. 8A, in the ZnO system, the addition of a scavenger of radicals (*t*-BuOH) only caused a small change in the photodegradation of MB. On the contrary, the photocatalytic activity of ZnO could be greatly suppressed by the addition of a scavenger for holes (EDTA-2Na). This result suggested that the photogenerated holes were the main oxidative species of the ZnO system. In the C_3N_4/ZnO system (see Fig. 8B), the photocatalytic activity was greatly prevented by the EDTA-2Na, indicating the main oxidative species is the same as that of ZnO.

As discussed above, the crystal phase structure and surface area was not evidently changed and the limited adsorptivity enhancement was not the major factor of the significant enhancement of the photocatalytic activity of ZnO (enhanced about 3.5 times). The significant enhancement of photocatalytic activity was mainly due to the high efficiency of charge separation induced by the hybrid effect of C_3N_4 and ZnO. A schematic for electron-hole separation and transportation at the C_3N_4/ZnO photocatalyst interface is shown in Fig. 9. ZnO can be excited by UV light and produce photogenerated electron-hole pairs, showing photocatalytic activity. Since the valence band (VB) position of ZnO is lower than the highest occupied molecular orbital (HOMO) of C_3N_4 ,^{32,40} the photogenerated holes on ZnO could directly transfer to C_3N_4 , making charge separation more efficient and reducing the probability of photogenerated electron-hole recombination, leading to an enhanced photocatalytic activity.

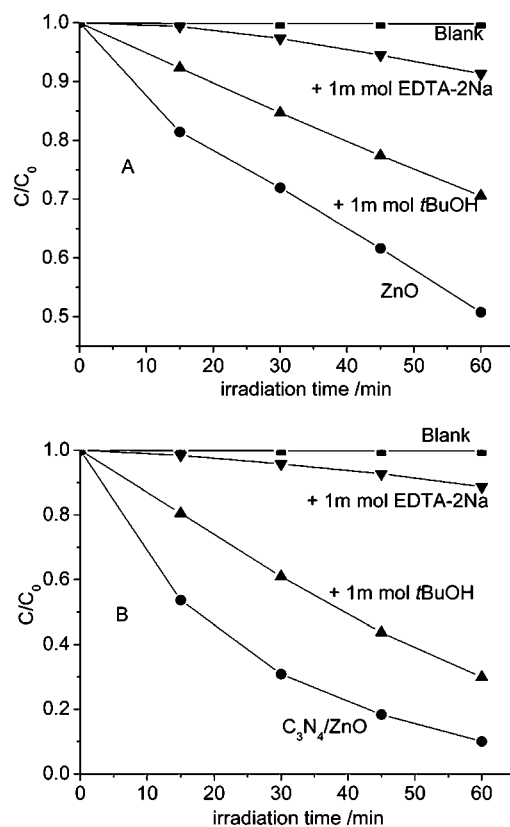
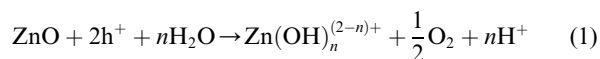


Fig. 8 The plots of photogenerated carriers trapping in the system of photodegradation of MB by (A) ZnO and (B) C_3N_4/ZnO under UV light irradiation.

As shown above, beyond the higher photocatalytic activity, the presence of C_3N_4 could effectively enhance the photostability of ZnO photocatalyst. Many reports have suggested that ZnO semiconductor suffers from a significant decrease in photocatalytic activity due to the photoinduced dissolution.²⁰ The photocorrosion process of ZnO can be presented as follows:



where n depends on the pH of the solution.²⁰ As can be seen from eqn (1), the photoinduced holes participate in the photocorrosion

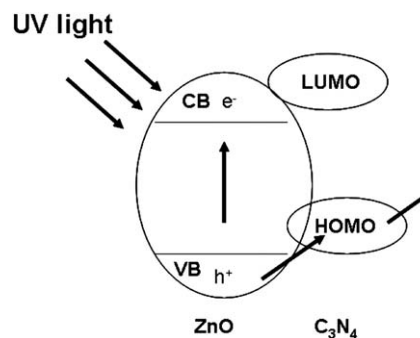


Fig. 9 Schematic drawing illustrating the mechanism of charge separation and photocatalytic activity of the C_3N_4/ZnO photocatalyst under UV light irradiation.

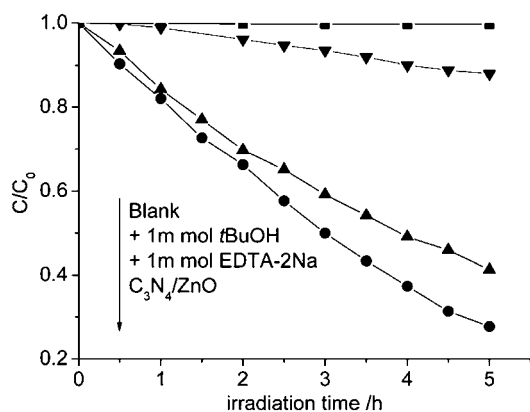


Fig. 10 The plots of photogenerated carriers trapping in the system of photodegradation of MB by C_3N_4/ZnO -3% under visible light irradiation.

and destroy the crystal structure of ZnO. As a result, the photocatalytic activity of ZnO is greatly decreased. After introduction of C_3N_4 to ZnO, the photogenerated holes on ZnO could transfer to C_3N_4 , and then effective photocorrosion inhibition is achieved.

Mechanism of visible photoactivity

As it is well known that ZnO itself can not be excited by visible light, the trapping experiments of radicals and holes were only performed on C_3N_4/ZnO -3% photocatalyst. As can be seen from Fig. 10, the photodegradation of MB was obviously suppressed after the injection of *t*-BuOH. This result suggests that radicals are the main oxidative species in this system. On the basis of the results of photodegradation and photogenerated carrier trapping test, a proposed schematic mechanism of the visible light activity of the C_3N_4/ZnO photocatalyst is shown in Fig. 11. C_3N_4 absorbs visible light to induce $\pi-\pi^*$ transition, transporting the excited-state electrons from the HOMO to the lowest unoccupied molecular orbital (LUMO). The LUMO potential of C_3N_4 (-1.12 eV)³² is more negative than the conduction band (CB) edge of ZnO (-0.5 eV),²⁰ so the excited electron on C_3N_4 could directly inject into the CB of ZnO. $C_3N_4^+$ would accept electrons from fragments of MB degradation and return to the ground state. The electrons would subsequently transfer to the

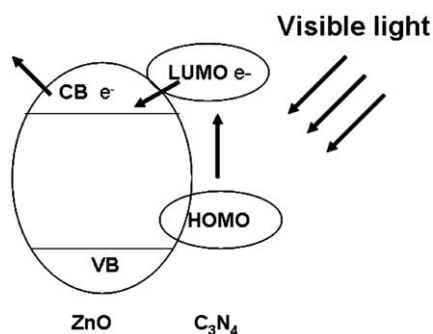


Fig. 11 Schematic drawing illustrating the mechanism of charge separation and photocatalytic activity of the C_3N_4/ZnO photocatalyst under visible light irradiation.

photocatalyst surface to react with water and oxygen to generate superoxide and hydroxyl radicals. The radicals are able to oxidize the pollutant due to their high oxidative capacity, producing visible light photocatalytic activity.

Conclusion

A C_3N_4/ZnO photocatalyst was successfully synthesized via a facile chemisorption. After introduction of C_3N_4 , the photocurrent of ZnO was enhanced by 5 times under UV light irradiation and a noticeable photocurrent was observed under visible light irradiation. The C_3N_4/ZnO photocatalyst possessed significantly enhanced UV light photocatalytic activity, visible light photocatalytic activity and excellent antiphotocorrosion ability. The performance enhancement and photocorrosion inhibition under UV light irradiation were induced by the high separation efficiency of photoinduced charges. The visible photoactivity originated from the injection of excited electrons from the LUMO of C_3N_4 to the CB of ZnO. C_3N_4 hybridization is demonstrated to be a promising approach to design highly active and stable ZnO photocatalysts.

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